

Preparation and Characterization of Nanocrystalline Cerium (IV) Oxide and Doped Cerium (IV) Oxide, $Ce_{1-x-y}Mg_xZr_yO_{2-\delta}$

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Abstract

Nanocrystalline cerium (IV) oxide is a technologically important material due to its high oxygen storage capacity, oxygen ionic conductivity and thermal stability. In this paper we report preparation of nanocrystalline CeO_2 using glycerin nitrate method, where the precursor obtained from the mixture of cerium nitrate and glycerin were calcined at temperatures ranging from 200°C to 800°C in steps of 100°C in a muffle furnace. Attempts were also made to prepare nanocrystalline cerium (IV) oxide doped with both Mg and Zr using the same method. The calcined specimens were characterized using XRD, FTIR and SEM/EDX analyses. The influence of the calcination temperature on the cubic phase formation and its consequent effect on the crystallite size of the prepared CeO_2 were studied and interpreted. The crystallite sizes calculated from XRD data using Scherrer formula reveal that the phases are nanocrystals, which was further supported by SEM photograph. The apparent activation energy for crystalline coarsening is found to be very low (26.8 kJmol⁻¹) for this precursor compared to reported data. XRD data and also EDX analysis shows that both Mg and Zr could also be doped in CeO_2 upto a certain composition, $Ce_{1-x-y}Mg_xZr_yO_{2-\delta}$ ($x = 0.05$, $y = 0.05$).

Keywords: Ceria; Zirconia; Magnesium oxide; Oxygen storage capacity; Nanocrystal.

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1. Introduction

Cerium (IV) oxide, also called ceria (CeO_2) is one of the most interesting materials of rare earth family and has received more attention to researchers due to its multidimensional applications. Major potential applications of CeO_2 are ultraviolet radiation absorbent [1], catalytic support or promoter [2], oxygen ion conductor in solid oxide fuel cells (SOFCs) [3], gas sensor [4], hybrid solar cells [5], H_2S removal [6], luminescent materials for

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violet/blue fluorescence [7], water gas shift reaction, oxidative dehydrogenation [8] etc. CeO₂ can be applied in these fields due to its structural and chemical properties such as oxygen storage capacity, high surface area, thermal stability, high hardness index and its reactivity [9]. Oxygen storage capacity of ceria can be explained by switching between Ce⁴⁺ and Ce³⁺ depending on ambient oxygen partial pressure with generation of lattice defect (oxygen vacancy). These properties of ceria can be further enhanced via doping, i.e. partial substitution of cerium by other cations in its crystal lattice to create vacancies, and via preparing nanocrystals to create surface crystal defects for more active sites [10-12]. This offers a great opportunity to control the activity and selectivity of oxide catalysts with the aid of innovative nanofabrication techniques. Shapovalov *et al.* [13] reported that bonds between lattice oxygen and metal atoms in oxide are significantly weakened by the presence of dopants and hence the doped CeO₂ surfaces, e.g., (111) plane, become much more active. Several papers have been published about doped CeO₂ with various cations-dopants, such as Ca, Al, Zr, Nd, Pb, Mn, Mg, Cu, Zn, Co, Y, Ba and Sr [14-28].

Literature survey shows that nanocrystalline ceria have been prepared by means of a variety of methods such as sol-gel process [29], hydrothermal or solvothermal synthesis [30, 31], micro-emulsion [32], co-precipitation [33, 34], conventional solid state method, flow method [35], microwave hydrothermal method [36], sonochemical synthesis [37], thermal decomposition [38], spray pyrolysis [39] etc. These methods operate mainly on high pressure, salt-solvent mediated high temperature or surface capping agent and the sizes of ceria particles are relatively large. Therefore, search for a simple approach for low-cost, large-scale, controlled growth of ceria nanoparticles at ambient pressure seems to be important. Here we report preparation of nanocrystalline cerium (IV) oxide by using glycerin nitrate method which is a simple process, easy to scale-up and of low cost. We also used the same method for the preparation different new materials [40]. Moreover, attempts were also made to prepare doubly doped CeO₂ containing both Mg and Zr cations with nominal compositions Ce_{1-x-y}Mg_xZr_yO_{2-δ} (x = 0.05, y = 0.05, δ = oxygen deficiency) for the first time using this method.

2. Experimental

Reagent grade chemicals were used throughout the synthesis of the materials. Cerium nitrate was mixed with glycerin in a beaker with mole ratio of cerium to glycerin 1:2. The resulting mixture was heated at 120°C in an oven. During this heating process the cerium nitrate reacts with glycerin with the evolution of NO_x, CO₂ and water vapor [41] and led to the formation of foamy precursor. This precursor was calcined in a muffle furnace at temperature ranging from 200°C to 800°C in steps of 100°C for 6 hours in each case to get the desired products. To prepare CeO₂ doped with both Mg and Zr, corresponding metal nitrates with required stoichiometric ratio were mixed in glycerin in such a proportion that mole ratio of total metal ions to glycerin remains about 1:2. Then the same procedure was followed as mentioned above for calcinations.

The samples were characterized using different techniques such as X-ray powder diffraction (XRD), FTIR spectroscopy, scanning electron microscopy (SEM) and energy dispersive X-ray spectroscopy (EDX). XRD data of the prepared samples were recorded with a Philips PW-1830 X-ray generator in an XDC-700 Guinier Hagg focusing camera (Operating Voltage and Current 40kV and 30mA respectively) using $\text{CuK}\alpha_1$ radiation ($\lambda = 1.540598\text{\AA}$). The XRD were recorded in an image plate which was scanned using HD-CR 35 NDT/ CR 35 NDT scanner. IR absorption spectra were taken on a Perkin-Elmer FTIR spectrometer. For the IR spectroscopic measurements 1.0 mg of the finely ground sample was dispersed into 199 mg KBr and pressed into a pellet (13 mm diameter). The spectrum of a pure KBr pellet prepared in the same way was used as a reference. Spectra are given in absorbance units ($-\log(I/I_0)$, where I_0 , I are transmitted intensities through “reference” and “reference + sample”, respectively). SEM images and EDX spectra were recorded using JEOL analytical scanning electron microscope (model JSM-6490LA).

3. Results and Discussions

3.1. Characterization of CeO_2

3.1.1. XRD analysis

The XRD patterns of the resulting products obtained after heating the organic precursor of CeO_2 at different temperatures are shown in Fig. 1. All the lines in the XRD patterns could be perfectly indexed as fluorite type cubic crystal structure of CeO_2 . In addition, the diffraction peaks only become sharper (Fig. 1) with increasing calcination temperature, which reveals the change in crystallite size with calcination temperature. The lattice parameters of the products were calculated using the program Win Xpow and are listed in Table 1. The calculated lattice parameters fit very well with the reported literature values.

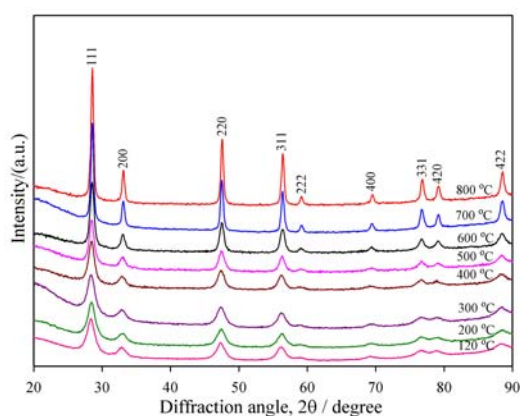


Fig.1. XRD patterns of the resulting product obtained after heating the precursor at different temperature. The diffraction patterns are shifted vertically and 2θ is shown from 20° for the sake of clarity.

From XRD patterns crystallite sizes were calculated using Scherrer equation and listed in Table 1. It is clearly revealed that with increase in calcination temperature crystallite size increases. The crystallite sizes of CeO₂ prepared in the range of 200 - 800°C are in the range of nanoscale. The low temperature (~200°C) formation of CeO₂ allows one to tailor the crystallite sizes in a high range of temperatures.

Table1. Calculated crystallite size of cerium (IV) oxide obtained after heating the precursor at different temperature using Scherrer equation.

Calcination temperature (°C)	Lattice parameter, $a / \text{Å}$	Crystallite size (nm)
200	5.414(9)	13
300	5.411(8)	14
400	5.414(6)	15
500	5.412(7)	17
600	5.413(7)	19
700	5.414(6)	22
800	5.413(4)	27

*Standard deviations of lattice parameters are given in parenthesis.

The crystallite coarsening behaviors of the glycerin-nitrate based precursor derived CeO₂ has been studied up to 800°C and the results are graphically shown in Fig. 2. It can be seen that crystallite sizes exponentially increases with increasing calcination temperature, which indicates the crystalline coarsening process is related to diffusion [42]. Crystallite growth kinetic generally follows the empirical equation [43]: $D^n - D_0^n = kt$. where, D is the mean crystallite size at the time t , D_0 is the average initial crystallite size, n is the kinetic crystallite growth exponent which, can assume an integer value ranging from 1 to 4 depending upon various kinetic aspects in the coarsening process and k is a temperature dependent rate parameter.

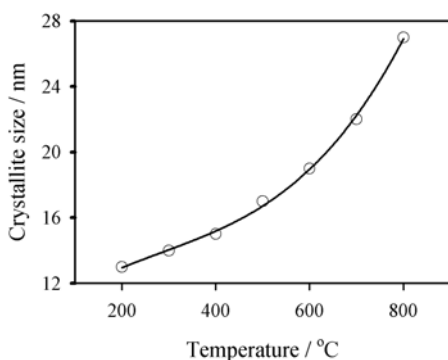


Fig. 2. Crystallite sizes of CeO₂ as a function of calcination temperature.

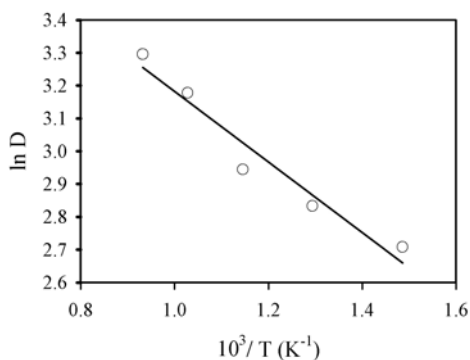


Fig. 3. A plot of $\ln D$ against reciprocal temperature for calculating apparent E_a

The apparent activation energy, E_a for a crystalline growth process can be calculated using the relation, $k = A \exp(-E_a/RT)$, where A is a constant, R is the gas constant and T is the absolute temperature. For $D \gg D_0$ and a constant crystallite growth time t , which is here the time required for a complete crystallite growth at a given temperature, the slope of the plot of $\ln D$ against $1/T$ is equal to $-E_a/nR$. Considering D_0 as crystallite size at 200°C, it is found that the coarsening of CeO₂ powder follows the cubic law ($n = 3$). Fig. 3 shows the Arrhenius plot constructed from the data given in Table 1 for CeO₂, in which $\ln D$ is plotted as a function of $1/T$. The values of the apparent activation energy E_a for crystallite growth are calculated from the slope of the lines and value of n . The apparent activation energy for crystallite growth of CeO₂ found in this work is 26.8 kJmol⁻¹, which is much lower value compared to reported for the CeO₂ prepared via thermal decomposition of ammonium ceric nitrate (65 kJmol⁻¹) [44], carbonate precipitate (68.7 kJmol⁻¹) [42], cerous oxalate (125 kJmol⁻¹) [44], cerous nitrate (203 and 46 kJmol⁻¹) [44], and hydrated cerium oxides (157 and 231 kJmol⁻¹) [45]. This phenomenon reveals that the crystallite coarsening behavior and mechanism are precursor dependent. And such a low value (26.8 kJmol⁻¹) of apparent activation energy for coarsening of CeO₂ found in the present study indicates that cation transport is likely surface-diffusion related as reported for thermal decomposition of carbonate-precipitate [42].

3.1.2. Scanning electron microscopy (SEM)

SEM images of two selected samples are given in Fig. 4, which shows those particles are spherical in shape and sizes are in the range of nanoscale (< 100 nm), a morphology more suitable to consolidation and ceramic fabrication [42]. Thus, from XRD analysis and SEM image, formation of nanocrystalline CeO₂ was confirmed.

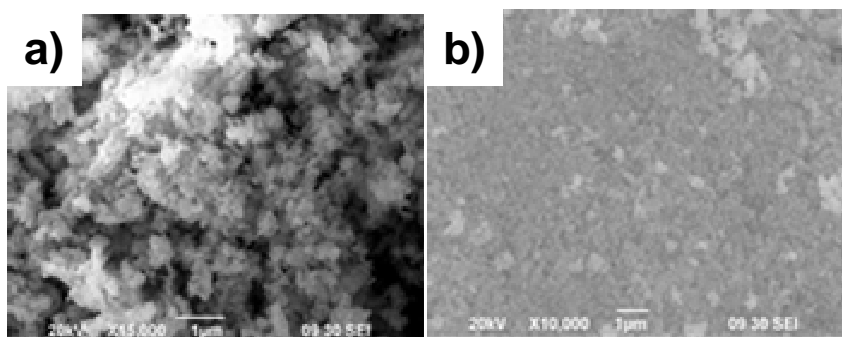


Fig. 4. SEM images of the CeO₂ obtained after heating the precursor at (a) 800°C and (d) 500°C temperature.

3.2. Characterization of $Ce_{1-x}D_xO_{2-\delta}$ ($D = Mg, Zr$ and $x = 0.10$) and $Ce_{1-x-y}Mg_xZr_yO_{2-\delta}$ ($x = 0.05, y = 0.05$)

3.2.1. XRD analysis

The XRD patterns of Mg doped CeO_2 , Zr doped CeO_2 as well as both Mg and Zr doped CeO_2 are shown in Fig. 5. There exists exactly equal number of lines as in powder pattern of CeO_2 , which indicates the incorporation of both Mg and Zr in CeO_2 lattice.

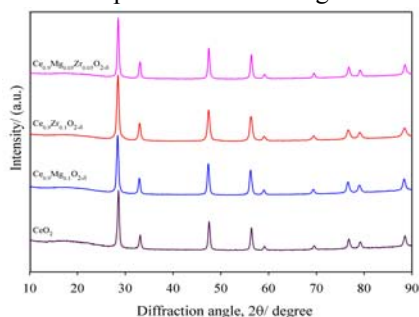


Fig. 5. XRD patterns of $Ce_{1-x}D_xO_{2-\delta}$ ($D = Mg, Zr$ and $x = 0.10$) and $Ce_{1-x-y}Mg_xZr_yO_{2-\delta}$ ($x = 0.05, y = 0.05$). The diffraction patterns are shifted vertically and 2θ is shown from 10° for the sake of clarity

There is no significant change in peak positions and relative intensities of XRD lines for doped samples which ensure the retainment of fluorite crystal structure. XRD patterns of these compounds indicate successful doping of Mg and Zr in CeO_2 lattice and the doping level is upto 10%, which has been observed for related system with different dopants [16, 23-28]. The crystallite sizes of these doped samples were calculated using Scherrer equation which revealed that Mg and Zr doped ceria prepared at $800^\circ C$ posses crystallite sizes in the range of 22-26 nm.

3.2.2. EDX spectroscopy

The presence of doped elements (Mg, Zr) were confirmed by EDX. EDX spectrum of sample with nominal composition $Ce_{1-x-y}Mg_xZr_yO_{2-\delta}$ ($x = 0.05, y = 0.05$) is shown in Fig. 6. In the spectrum, the peaks are identified as O(K), Mg(K), Zr(L) and Ce(L) at respective positions, which indicates successful doping of both Mg and Zr in CeO_2 .

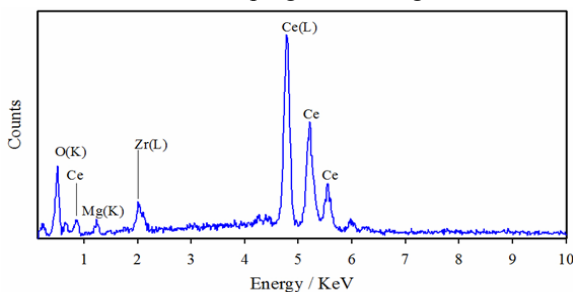


Fig. 6. EDX spectra of $Ce_{0.9}Mg_{0.05}Zr_{0.05}O_{2-\delta}$

3.2.3. FTIR spectrum analysis

FTIR absorption spectrum of $\text{Ce}_{1-x}\text{D}_x\text{O}_{2-\delta}$ (D = Mg, Zr and $x = 0.10$) and $\text{Ce}_{1-x-y}\text{Mg}_x\text{Zr}_y\text{O}_{2-\delta}$ ($x = 0.05$, $y = 0.05$) are shown in Fig. 7.

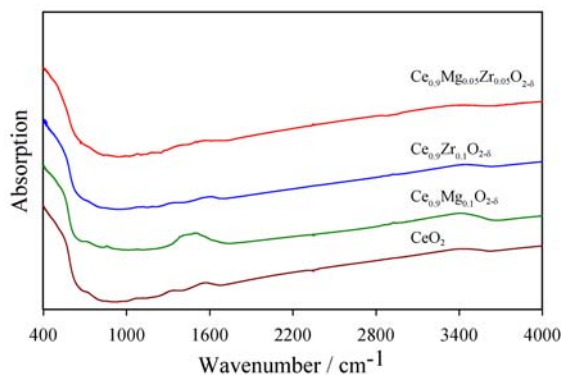


Fig. 7. FTIR absorption spectrum of products (as denoted) prepared at 800°C and measured in the range of 400 cm^{-1} - 4000 cm^{-1} .

The strong band below 700 cm^{-1} wavenumber can be assigned as Ce-O vibration. The spectra shows presence of two broad bands at band at 1569 cm^{-1} and 3435 cm^{-1} for $\text{Ce}_{0.9}\text{Mg}_{0.1}\text{O}_{2-\delta}$ which is related to H-O-H bending and O-H stretching mode of vibration of water. The source of these bands can be described considering the surface absorption of atmospheric moisture by rare earth Mg doped ceria. The amount of absorption increases with the increase in surface area, which is directly related to the decrease in particle size. The XRD data shows that $\text{Ce}_{0.9}\text{Mg}_{0.1}\text{O}_{2-\delta}$ has lowest crystallite size among $\text{Ce}_{0.9}\text{Mg}_{0.1}\text{O}_{2-\delta}$, $\text{Ce}_{0.9}\text{Zr}_{0.1}\text{O}_{2-\delta}$ and $\text{Ce}_{0.9}\text{Mg}_{0.05}\text{Zr}_{0.05}\text{O}_{2-\delta}$ so, have higher surface area and would show higher absorption of moisture from air.

4. Conclusion

Nanocrystalline CeO_2 were prepared using glycerin nitrate method, where the precursor obtained from the mixture of cerium nitrate and glycerin were calcined at temperatures ranging from 200°C to 800°C in steps of 100°C in a muffle furnace. The XRD study reveals that the structure of the system is fluorite type. Crystallite size were calculated using Scherrer equation and shows that crystallite size increases systematically with increasing calcination temperature and all the calcined product belongs to nanocrystal. SEM images also confirm the formation of nanocrystalline ceria. The size of the crystallites can be easily monitored by acting on annealing temperature. The apparent activation energy for crystalline coarsening is found to be very low (26.8 kJmol^{-1}) for this precursor compared to reported data. Using the same method, doubly doped CeO_2 containing both

Mg and Zr has been prepared for the first time. EDX analysis confirms the presence of both dopants (Mg and Zr) in ceria. For doping level upto 5% Mg and 5% Zr products show fluorite type cubic crystal structure with no extra line on their XRD patterns. Crystallite size of doubly doped compounds also belongs to nanoscale.

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